

L Number	Hits	Search Text	DB	Time stamp
1	0	245/? and plastic and mold\$3 and streak\$3 and spectrometer and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:12
2	0	245/? and plastic and mold\$3 and defect and spectrometer and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:12
3	0	245/? .ccls. and plastic and mold\$3 and (streak\$3 or defect) and spectrometer and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:13
4	0	250/? .ccls. and plastic and mold\$3 and (streak\$3 or defect) and spectrometer and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:14
5	0	250/? .ccls. and plastic and mold\$3 and (streak\$3 or defect) and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:13
6	0	356/? .ccls. and plastic and mold\$3 and (streak\$3 or defect) and spectrometer and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:24
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8	0	356/? .ccls. and plastic and mold\$3 and (streak\$3 or defect) and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:15
9	0	356/? .ccls. and plastic and mold\$3 and defect and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:15
10	0	356/? .ccls. and (plastic and mold\$3 and defect and @ad<19990503)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:20
11	72	(plastic and mold\$3 and (streak\$3 or defect) and spectrometer) and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:19
12	1	((plastic and mold\$3 and (streak\$3 or defect) and spectrometer) and @ad<19990503) and part same quality	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:17

13	32	((plastic and mold\$3 and (streak\$3 or defect) and spectrometer) and @ad<19990503) and inject\$4 near3 mold\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:19
14	10	264/? .ccls. and (plastic and mold\$3 and defect and @ad<19990503)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:21
15	1	703/? .ccls. and (plastic and mold\$3 and defect and @ad<19990503)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:22
16	0	703/? .ccls. and (defect and spectrometer and @ad<19990503)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:23
17	7	703/? .ccls. and (spectrometer and @ad<19990503)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:23
18	0	702/? .ccls. and plastic and mold\$3 and (streak\$3 or defect) and spectrometer and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:25
19	0	702/? .ccls. and plastic and mold\$3 and (streak\$3 or defect) and spectro\$6 and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:25
20	0	702/? .ccls. and mold\$3 and (streak\$3 or defect) and spectro\$6 and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:25
21	1	702/? .ccls. and (streak\$3 or defect) and spectro\$6 and @ad<19990503	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/01 16:25